## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination LOCHER ET AL. | Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	U.	Locher, et al., "Large Diameter Sapphire Window from Single Crystal Sheets," Proceedings of teh 5th DOD Electromagnetic Window Symposium, October 1993.				
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.